

<b>Notice of References Cited</b>	Application/Control No. 10/666,977	Applicant(s)/Patent Under Reexamination BLOESCH ET AL.	
	Examiner Todd Ingberg	Art Unit 2193	Page 1 of 4

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,385,724	05-2002	Beckman et al.	713/167
*	B	US-6,829,770	12-2004	Hinson et al.	719/318
*	C	US-6,748,555	06-2004	Teegan et al.	714/38
*	D	US-6,487,665	11-2002	Andrews et al.	726/26
*	E	US-6,714,962	03-2004	Helland et al.	709/203
*	F	US-6,604,198	08-2003	Beckman et al.	713/167
*	G	US-6,748,455	06-2004	Hinson et al.	719/318
*	H	US-6,574,736	06-2003	Andrews, Anthony D.	726/21
*	I	US-6,442,620	08-2002	Thatte et al.	719/316
*	J	US-6,606,711	08-2003	Andrews et al.	726/7
*	K	US-6,425,017	07-2002	Dievendoff et al.	719/315
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Aspect-Oriented Programming, Gregory Kiczales et al, Xerox Parc, June 1997, 23 pages
	V	Can Aspect-Oriented Programming Lead to More Reliable Software, John Viega et al, IEEE, 2000, pages 19 - 21
	W	Aspect-Oriented Frameworks: the Design of Adaptable Operating Systems, P. Netinant et al, ACM, 2000, pages 61 - 62
	X	AspectJ: the Language and Support Tools, Erik Hilsdale et al, Xerox Parc, page 163 , ACM

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/666,977	Applicant(s)/Patent Under Reexamination BLOESCH ET AL.	
	Examiner Todd Ingberg	Art Unit 2193	Page 2 of 4

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Aspect-Oriented Programming in Java, Markus Voelter, 7 pages, November 28, 2001 print date
	V	Designing an Aspect-Oriented Framework in an Object-Oriented Environment, Constantinos A. Constantinides et al, ACM, 2000, pages 1 - 12
	W	An Initial Assessment of Aspect-Oriented Programming, Robert J. Walker et al, ACM, pages 120-130, 1999
	X	The First Aspect-Oriented Compiler, Larry O'Brien, Xerox PARC, September 2001, 5 pages

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/666,977	Applicant(s)/Patent Under Reexamination BLOESCH ET AL.	
	Examiner Todd Ingberg	Art Unit 2193	Page 3 of 4

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	AspectJ 0.8b5: Real-world AOP tool simplifies Oo development, Rich Price, JAVA Report, print date November 2001, 5 pages
	V	Early Definition of Aspect-Oriented Programming, www.ccs.neu.edu, print date November 2001, 3 pages
	W	Thoughts on Aspect Oriented Programming, print date November 2001, 3 pages
	X	Aspect-Oriented Programming, ACM, October 2001 pages 28-41, 43-57, 59-65, 67-73, 75-77, 79-85, 87-93, 95-97

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/666,977	Applicant(s)/Patent Under Reexamination BLOESCH ET AL.	
	Examiner Todd Ingberg	Art Unit 2193	Page 4 of 4

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Workflow Template Process Template - Developing a WFT Workflow System", Template Software, 1998, whole book
	V	Workflow Template Process Template - Using the WFT Development Environment ", Template Software, 1998, whole book
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.